



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant THOMAS HUBERT VAN STEENKISTE Art Unit 3752

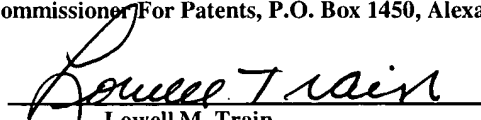
Attorney Docket Number DP-308960

Serial 10/808246
No.

Filed March 24, 2004

Title IMPROVED KINETIC SPRAY NOZZLE DESIGN FOR SMALL SPOT
COATINGS AND NARROW WIDTH STRUCTURES

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class
mail in an envelope addressed to: MS: DD - Patents, Commissioner For Patents, P.O. Box 1450, Alexandria, VA 22313-
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Lowell M. Train

STATEMENT ACCOMPANYING
INFORMATION DISCLOSURE STATEMENT

Applicant(s) requests the Examiner to consider and make of record the reference(s) and/or
information on attached PTO 1449.

CHECK ONE: (A, B, or C.)

- ☐ A. This statement is submitted within 1) three months after the filing date (even if after the first action); or 2) within three months of the date of entry of the national stage or 3) before the mailing date of a first Office Action. No fee or statement is required.
- ☒ B. This statement is submitted after the period specified in para. A, but before Final Office Action or Notice of Allowance or the close of prosecution.

CHECK ONE: (1, 2, or 3)

- ☐ 1. I hereby state that each item of information contained in the information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement; or
- ☐ 2. I hereby state that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the certification after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the information disclosure statement.

☒ 3. Charge the fee set forth in § 1.17(p) to Delphi Technologies, Inc. Deposit Account No. 50-0831.

☐ C. This statement is submitted after a Final Office Action or Notice of Allowance or the close of prosecution, but before payment of the issue fee. Charge the fee set forth in § 1.17(p) to Delphi Technologies, Inc. Deposit Account No. 50-0831.

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☐ 1. I hereby state that each item of information contained in the information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement; or

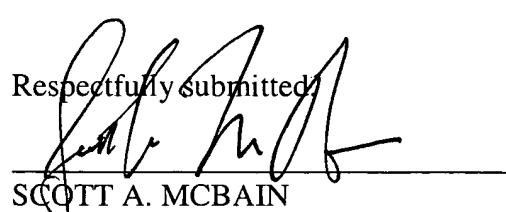
☐ 2. I hereby state that no item of information contained in the information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing the certification after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in § 1.56 (c) more than three months prior to the filing of the information disclosure statement.

REMARKS UNDER 1.98 (a)(3)

Each of the cited references is relevant in that it was cited in a foreign counterpart application.

Please consider the attached reference(s) which have come to the attention of Applicants since the last submission of an IDS. If any fee should be required, please charge the appropriate fee to Delphi Technologies, Inc. Deposit Account No. 50-0831.


Respectfully submitted,


SCOTT A. MCBAIN

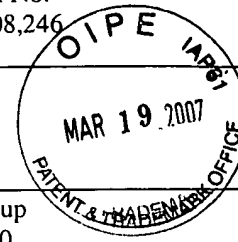
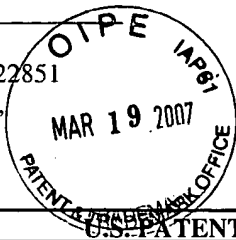
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Telephone (248) 813-1235

Enclosure: PTO 1449

INFORMATION DISCLOSURE CITATION WITH DOCUMENT COPIESSubmitted by: Atty. Docket No.
DP-308960Serial No.
10/808,246SCOTT A. MCBAIN
CUSTOMER NUMBER 22851
Delphi Technologies, Inc.,Applicant
Van Steenkiste

Reg. No. 37181

Filing Date
March 24, 2004Group
1170**U.S. PATENT DOCUMENTS**

Exam. Init.	Document Number	Date	Name	Class	Sub Class	Filing Date (if approp.)
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Document Number	Date	Country	Class	Subclass	Translation Yes No
03009934	02/06/2003	WO			Yes
04180770	06/26/1992	JP			Abstract Only
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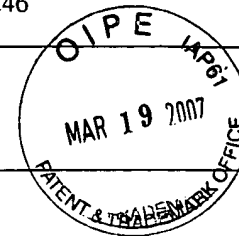
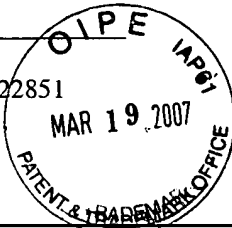
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SCOTT A. MCBAIN CUSTOMER NUMBER 22851 Delphi Technologies, Inc.	Applicant Van Steenkiste	
Reg. No. 37181	Filing Date 03-24-2004	Group 1170

**U.S. PATENT DOCUMENTS**

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Document Number	Date	Country	Class	Subclass	Translation Yes No
42 36 911	12-23-1993	Germany			No
55031161	03-05-1980	Japan			Abstract Only
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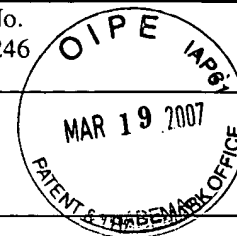
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1 160 348	12/05/2001	EP			Yes
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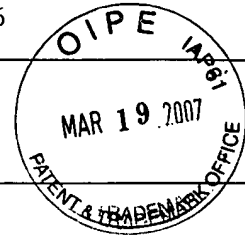
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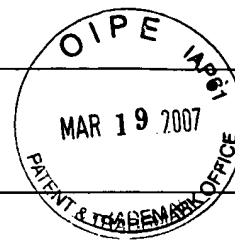
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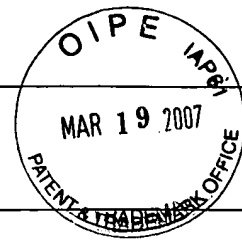
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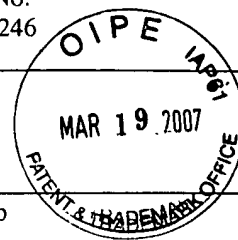
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